FCC TEST REPORT

For

TELEPHONE EST (HK) CO., LTD MIRROR WITH BLUETOOTH SPEAKER

Model No.: EL7040-RG, EL7040-SIL

Prepared For : TELEPHONE EST (HK) CO., LTD

Address : Room709, 7F, FuLi tianhe commercial building, Linhe East Road and

tianhe district, Guangzhou, China

Prepared By : Shenzhen Anbotek Compliance Laboratory Limited

Address : 1/F, Building D, Sogood Science and Technology Park, Sanwei

community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong,

China.518102

Tel: (86) 755-26066440 Fax: (86) 755-26014772

Report Number : SZAWW180830002-01

Date of Receipt : Aug. 30, 2018

Date of Test : Aug. 30~Sept. 14, 2018

Date of Report : Sept. 14, 2018



Contents

1. General Information					<u></u>
1.1. Client Information	ter A	Upo	k.	Popose.	Am
1.2. Description of Device (EUT)	wote ^K	Anbore	Vur.	hotek	Anbo
1.3. Auxiliary Equipment Used During	Test	botek	Anbo	Work,	k pubote.
1.4. Description of Test Modes	Anbo	r	10 duy	YALL P.	kootek
1.4. Description of Test Modes	Anbore	An		potek Anb	
1.6. Description Of Test Setup 1.7. Test Equipment List 1.8. Description of Test Facility	ody	ter Aut		wotek .	nbote Ani
1.7. Test Equipment List		wotek	Nupore.	Ann Hek	unotek Ani
1.8. Description of Test Facility	ν. Ν.		Robotek	Aupo	1
2. Summary of Test Results	boter	Anbe	- otek	Anbore	An
Summary of Test Results Conducted Emission Test	Notek.	Anbote	P.U.	sk kapotel	1
3.1 Test Standard and Limit					tek vupo 1
3.2. Test Setup	Anu		otek An	or All	1
3.3. Test Procedure	Anbo		4950	"upoter V	1
3 4 Test Data					Anbor An
4 Radiation Spurious Emission and Rand Fo	dae				aboten 1
4.1. Test Standard and Limit	po.	b. Hotek	Aupote,	Ant	1
4.2. Test Setup	Pupote.	VU.,	6b0ts	K Anbor	1
4.3. Test Procedure	hotek	Anbo		otek kupo	And 1
4.4. Test Data		ek sab	ote, Vui		
4.4. Test Data 5. Maximum Peak Output Power Test	Wir		,botek	Aupo. A	2
5. Maximum Peak Output Power Test	ek An	00. b	motek.	Aupore	2
5.2. Test Setup	otek	Anbore	Anv	hotek	Anbo
5.3. Test Procedure		botek	Anbo	w. wotek	2
5.4. Test Data	Anbe	votek	Anbore	Pur.	
5.3. Test Procedure	Anboro	P.L.	don	otek Anbo	3
6.1 Test Standard					, A
6.2. Test Setup		otek A	uporc P	'u.	botek
6.3. Test Procedure	. bi.	tek.	anbotek	Anbe	3
6.4. Test Data	oter	Anb.	, otek	Anbore	3
7. Carrier Frequency Separation Test	nkotek	Aupor.	P.,.	k Anboten	
7.1. Test Standard and Limit	er wotek	papote.	Amb	امىنىنىدى	3:
7.2. Test Setup	Vur.	, , , , , ,	tek Aup	bro.	3
7.3. Test Procedure	Anbor		Kolek	oboten An	3
7.4. Test Data	K PUD	ote. Ar		Modek	Anbou 3:
8. Number of Hopping Channel Test		upotek	Anbo.	A. Motek	3
8.1. Test Standard and Limit		wotek.	Aupote.	A ^{nu} ,ok	3
8.2. Test Setup	upoto	Vu. Yek	- thotek	Aupor	
8.3. Test Procedure	Kupotek	Anbo	54bs.	tek anboti	3'
8.4. Test Data	otel	k Anbol	Am.		3'
9. Dwell Time Test	An.	Hegk	poter A	100 By	4
6.3. Test Procedure	Anb		otek	Anbor	4



9.2. Test Setup	41
9.3. Test Procedure	41
9.4. Test Data	41
10. 100kHz Bandwidth of Frequency Band Edge Requirement	45
10.1. Test Standard and Limit	45
10.2. Test Setup	45
10.3. Test Procedure	45
10.4. Test Data	45
11. Antenna Requirement	50
11.1. Test Standard and Requirement	50
11.2. Antenna Connected Construction	50
APPENDIX I TEST SETUP PHOTOGRAPH	51
APPENDIX II EXTERNAL PHOTOGRAPH	53
APPENDIX III INTERNAL PHOTOGRAPH	57

Code:AB-RF-05-a



TEST REPORT

Applicant : TELEPHONE EST (HK) CO., LTD

Manufacturer : TELEPHONE EST ELECTRONICS FACTORY(ZHONG SHAN)

Product Name : MIRROR WITH BLUETOOTH SPEAKER

Model No. : EL7040-RG, EL7040-SIL

Trade Mark : ELLE

Rating(s) : DC 5V, 1A(with DC 3.7V, 1500 mAh Battery inside)

Test Standard(s) : FCC Part15 Subpart C 2017, Section 15.247

Test Method(s) : **ANSI C63.10: 2013**

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Prepared by

(Engineer / Tangcy Tang)

Reviewer

(Supervisor / Snowy Meng)

Approved & Authorized Signer

(Manager / Sally Zhang)



1. General Information

1.1. Client Information

Applicant	:	TELEPHONE EST (HK) CO., LTD
Address	:	Room709, 7F, FuLi tianhe commercial building, Linhe East Road and tianhe district, Guangzhou, China
Manufacturer	:	TELEPHONE EST ELECTRONICS FACTORY(ZHONG SHAN)
Address	:	No.2, Heyuan, Lianfeng Road, Xiaolan Town, Zhongshan City, Guangdong, China
Factory	:	TELEPHONE EST ELECTRONICS FACTORY(ZHONG SHAN)
Address	:	No.2, Heyuan, Lianfeng Road, Xiaolan Town, Zhongshan City, Guangdong, China

1.2. Description of Device (EUT)

Product Name	:	MIRROR WITH BLUETOOTH	SPEAKER					
Model No.	:	EL7040-RG, EL7040-SIL (Note: All samples are the same etest only.)	except the colour, so we prepare "EL7040-RG" for					
Trade Mark	:	ELLE TOK DOORSK	Anbotek Anbotek Anbotek					
Test Power Supply	:	AC 240V, 60Hz for adapter/ AC 2 DC 3.7V Battery inside	120V, 60Hz for adapter/					
Test Sample No.	:	S1(Normal Sample), S2(Engineering Sample)						
		Operation Frequency:	2402MHz~2480MHz					
		Transfer Rate:	1/2/3 Mbits/s					
Product		Number of Channel:	79 Channels					
Description		Modulation Type:	GFSK, π/4-DQPSK, 8-DPSK					
		Antenna Type:	PCB Antenna					
		Antenna Gain(Peak):	Q dBi					

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

1.3. Auxiliary Equipment Used During Test

5,	Adapter	:	Manufacturer: ZTE	10
n'			M/N: STC-A2050I1000USBA-C	1
			S/N: 201202102100876	
			Input: 100-240V~ 50/60Hz, 0.3A	
i.			Output: DC 5V, 1000mA	0

1.4. Description of Test Modes

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	CH00 Anbores Anbores Anbores
Mode 2	CH39
Mode 3	CH78
Mode 4	Keeping TX+ Charging Mode

	For Conducted Emission
Final Test Mode	Description
Mode 4	Keeping TX+ Charging Mode

	For Radiated Emission					
Final Test Mode	Description					
Mode 1	K hotek Anbote CH00 And tek obotek A					
Mode 2	CH39					
Mode 3	CH78					
Mode 4	Keeping TX+ Charging Mode					

Note:

- (1) The measurements are performed at the highest, middle, lowest available channels.
 - (2) The data rate was set in 1Mbps for radiated emission due to the highest RF output power.

1.5. List of channels

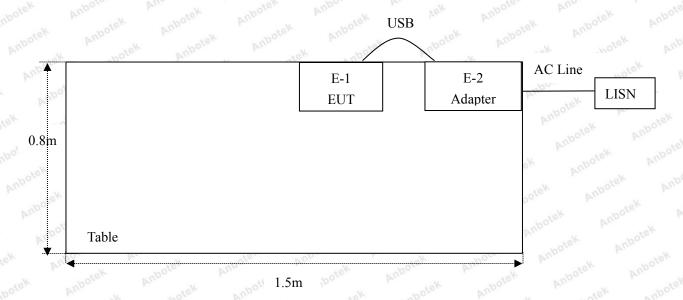
Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)
00	2402	Anb 17	2419	34	2436	51	2453	68	2470
01	2403	18° tel	2420	35	2437	52	2454	69	2471
02	2404	19	2421	36	2438	53	2455	70	2472
03	2405	20	2422	37	2439	54	2456	71	2473
04	2406	21	2423	38	2440	55	2457	72	2474
05	2407	22	2424	39	2441	56	2458	73	2475
05	2408	23	2425	40	2442	57	2459	74	2476
10 ¹ 07	2409	24	2426	41 Anio	2443	58	2460	75	2477
08	2410	25	2427	42	2444	59	2461	76	2478
09	2411	26	2428	43	2445	60	2462	ote*77	2479
An ⁰ 10	2412	27	2429	44	2446	61,000	2463	78	2480
phpoto	2413	28	2430	45	2447	62	2464		
12	2414	29	2431	46	2448	63	2465		
13	2415	30	2432	47 000	2449	64	2466	11111111	
14	2416	31	2433	48	2450	65	2467	1 100	
bote 15	2417	32	2434	49	2451	66	2468		
16	2418	33	2435	50	2452	67	2469		

Note:

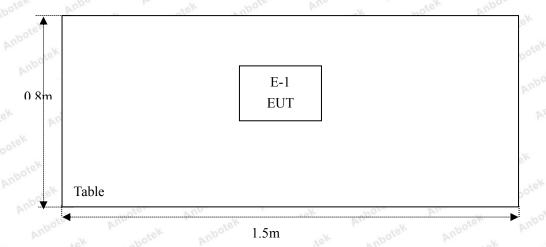
- 1. The engineering test program was provided and the EUT was programmed to be in continuously transmitting mode.
- 2. EUT built-in battery-powered, fully-charged battery use of the test battery.

1.6. Description Of Test Setup

CE



RE





1.7. Test Equipment List

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.
telt.	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Nov. 17, 2017	1 Year
12.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year
3.00	RF Switching Unit	Compliance Direction	RSU-M2	38303	Nov. 17, 2017	1 Year
4. 📈	Spectrum Analysis	Agilent	E4407B	US39390582	Nov. 17, 2017	1 Year
5.	MAX Spectrum Analysis	Agilent	N9020A	MY51170037	Nov. 18, 2017	1 Year
6.	Preamplifier	SKET Electronic	BK1G18G30D	KD17503	Nov. 17, 2017	1 Year
ootek 7.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Nov. 20, 2017	1 Year
8.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Nov. 20, 2017	1 Year
9.	Loop Antenna	Schwarzbeck	HFH2-Z2	100047	Nov. 17, 2017	1 Year
10.	Horn Antenna	Schewarzbeck	BBHA9170	9170-375	Nov. 17, 2017	1 Year
11.	Pre-amplifier	SONOMA	310N	186860	Nov. 17, 2017	1 Year
12.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A
13.	RF Test Control System	YIHENG	YH3000	2017430	Nov. 18, 2017	1 Year
14.	Power Sensor	DAER	RPR3006W	15I00041SN045	Nov. 17, 2017	1 Year
15.	Power Sensor	DAER	RPR3006W	15I00041SN046	Nov. 17, 2017	1 Year
16.	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Nov. 18, 2017	1 Year
17.	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Nov. 18, 2017	1 Year
18.	Signal Generator	Agilent	E4421B	MY41000743	Nov. 18, 2017	1 Year
19.	DC Power Supply	LW	TPR-6410D	349315	Nov. 01, 2017	1 Year
20.	Constant Temperature Humidity Chamber	Sertep	ZJ-HWHS80B	ZJ-17042804	Nov. 01, 2017	1 Year

1.8. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registed and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111, July 31, 2017.

ISED-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A-1, June 13, 2016.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

at 1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102



2. Summary of Test Results

Standard Section	Test Item	Result
15.203/15.247(c)	Antenna Requirement	PASS
15.207	Conducted Emission	PASS
15.205/15.209	Spurious Emission	PASS
15.247(b)(1)	Conducted Peak Output Power	PASS
15.247(a)(1)	20dB Occupied Bandwidth	PASS
15.247(a)(1)	Carrier Frequencies Separation	PASS
15.247(a)(1)	Hopping Channel Number	PASS
15.247(a)(1)	Dwell Time	PASS
15.247(d)	Band Edge	PASS

3. Conducted Emission Test

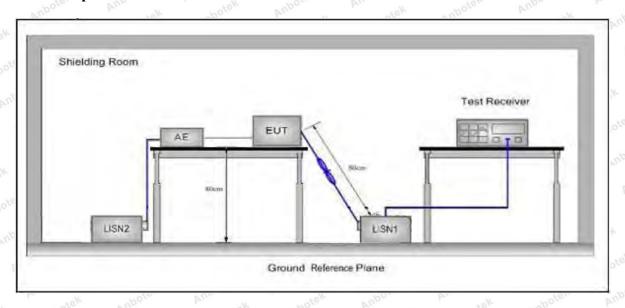
3.1. Test Standard and Limit

Test Standard	FCC Part15 Section 15.20	07 Anbote Ame	Anbotek Anbo tek				
	F	Maximum RF Line Voltage (dBuV)					
Test Limit	Frequency	Quasi-peak Level	Average Level				
	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *				
	500kHz~5MHz	56	46				
	5MHz~30MHz	60	50 botes Ar				

Remark: (1) *Decreasing linearly with logarithm of the frequency.

(2) The lower limit shall apply at the transition frequency.

3.2. Test Setup



3.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10-2013 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

3.4. Test Data

Please to see the following pages

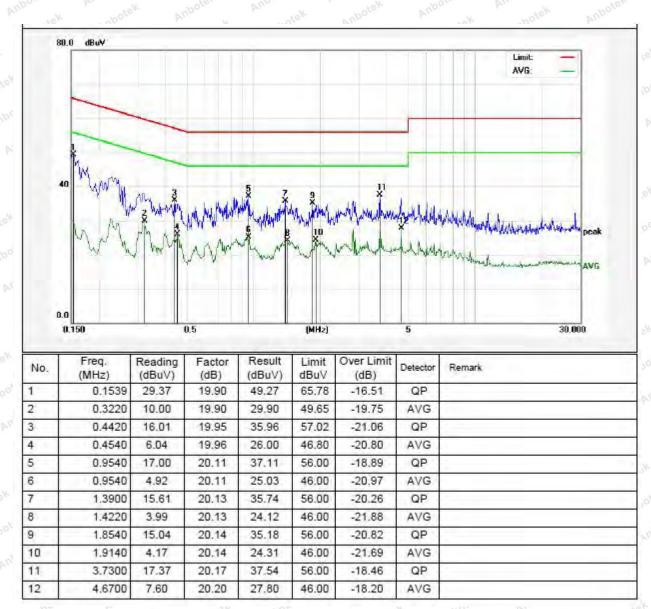
Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode Test Specification: AC 240V, 60Hz for adapter

Comment: Live Line

Tem.: 23.6°C Hum.: 57%





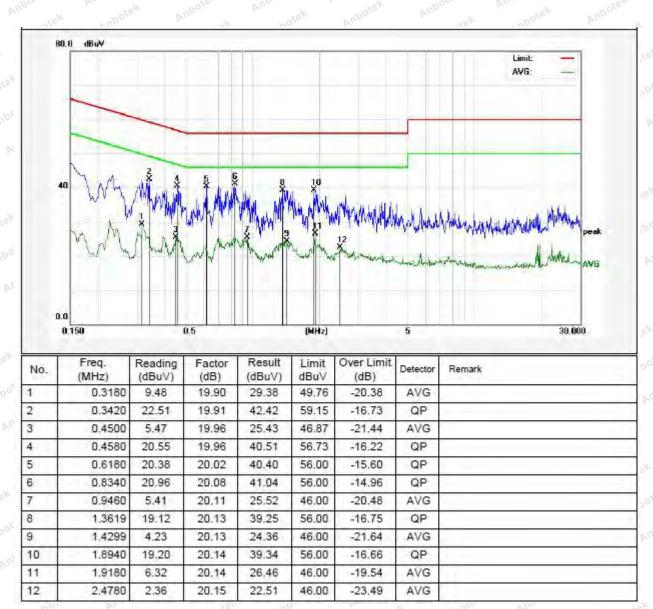
Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Neutral Line

Tem.: 23.6℃ Hum.: 57%



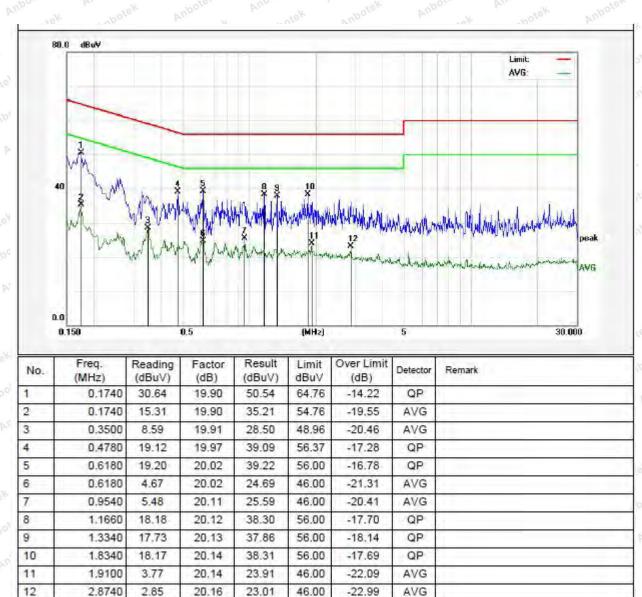
Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Live Line

Tem.: 23.6°C Hum.: 57%



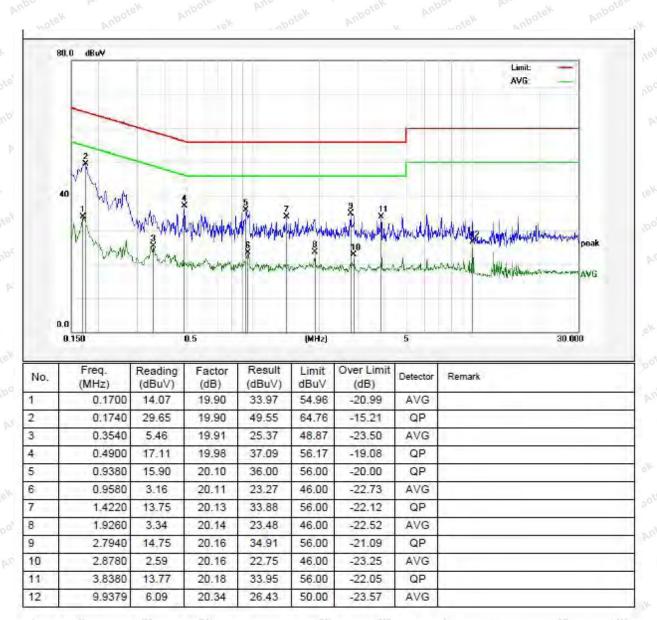
Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Neutral Line

Tem.: 23.6°C Hum.: 57%



4. Radiation Spurious Emission and Band Edge

4.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.20	99 and 15.205	Am	Anbotek	rupo, stek
	Frequency	Field strength	Limit	Remark	Measurement
	(MHz)	(microvolt/meter)	(dBuV/m)	1.0	distance (m)
	0.009MHz~0.490MHz	.490MHz 2400/F(kHz)		ek nbotel	300
	0.490MHz-1.705MHz	24000/F(kHz)	hotek - Anbi	stek - who	stek 30 Anbote
	1.705MHz-30MHz	30	Anboten A	loc tek	abotek 30 Anbi
Test Limit	30MHz~88MHz	100	40.0	Quasi-peak	Anbote3 A
	88MHz~216MHz	150	43.5	Quasi-peak	Anb3tek
	216MHz~960MHz	200	46.0	Quasi-peak	3,botek
	960MHz~1000MHz	500	54.0	Quasi-peak	kek 3 Ambotek
	Above 1000MHz	500	54.0	Average	botek 3 Anbo
	Adove 1000MHZ	All botek	74.0	Peak	ambote ¹ 3 A

Remark:

- (1)The lower limit shall apply at the transition frequency.
- (2) 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

4.2. Test Setup

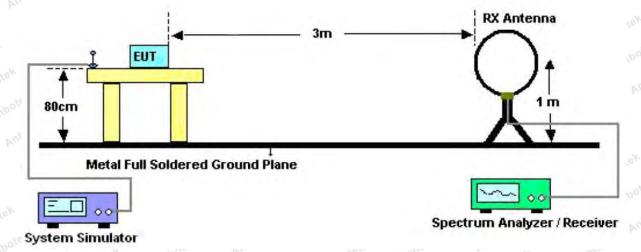


Figure 1. Below 30MHz



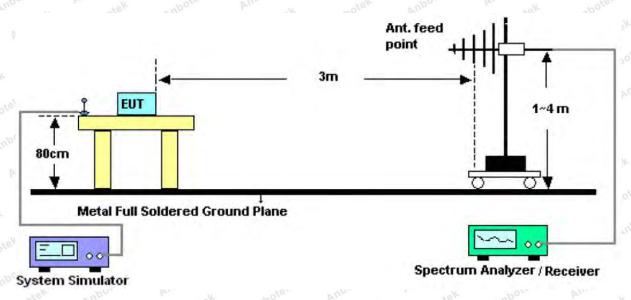


Figure 2. 30MHz to 1GHz

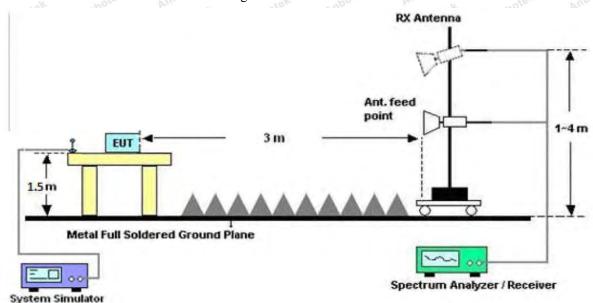


Figure 3. Above 1 GHz

4.3. Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.

For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. The device is evaluated in xyz orientation.

For the radiated emission test above 1GHz:

Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying

aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW = 1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as:

RBW = 9KHz, VBW = 30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as:

RBW = 100kHz, VBW =300kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For above 1GHz, Set the spectrum analyzer as:

RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple.

RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

4.4. Test Data

PASS

During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation which is worse case.

The test results of 9kHz-30MHz was attenuated more than 20dB below the permissible limits, so the results don't record in the report.

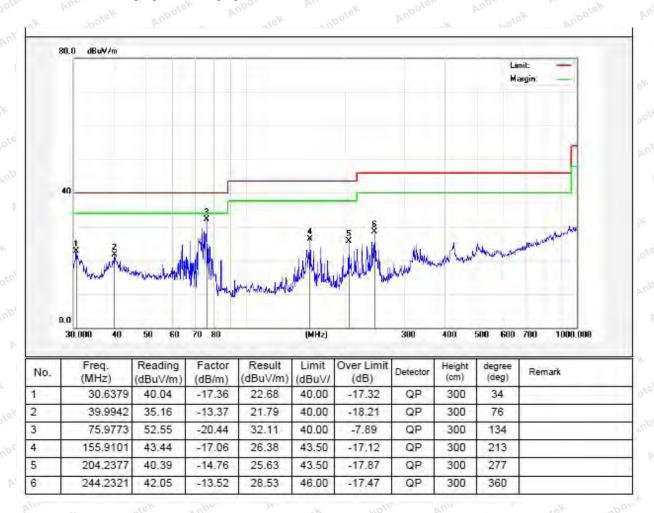


Test Results (30~1000MHz)

Job No.: SZAWW180830002-01 Temp.(°C)/Hum.(%RH): 23.2°C/53.4%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: Keeping TX+ Charging Mode Polarization: Horizontal



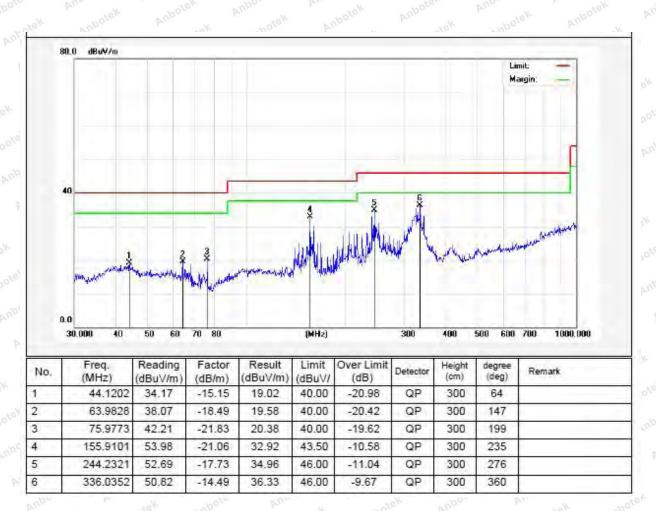


Test Results (30~1000MHz)

Job No.: SZAWW180830002-01 Temp.(°C)/Hum.(%RH): 23.2°C/53.4%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: Keeping TX+ Charging Mode Polarization: Vertical





Test Results (1GHz-25GHz)

Test Mode:	CH00			Test	channel: Low	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	35.97	34.04	6.58	34.09	42.50	74.00	-31.50	botek
7206.00	30.95	37.11	7.73	34.50	41.29	74.00	-32.71	AnbVel
9608.00	30.68	39.31	9.23	34.79	44.43	74.00	-29.57	V
12010.00	*	otek A	abotek P	Wpor.	anbotek .	74.00	Vup.	V
14412.00	*	*otek	Anbotek	Aupote,	An potek	74.00	Anb	ek V
4804.00	39.99	34.04	6.58	34.09	46.52	74.00	-27.48	H
7206.00	32.58	37.11	7.73	34.50	42.92	74.00	-31.08	H
9608.00	29.98	39.31	9.23	34.79	43.73	74.00	-30.27	Aupo.
12010.00	* nbote	Anb	otek .	nbotek	Aupore	74.00	Anbotek	PH
14412.00	lek * Anbr	yes by	lon to	upotek	Anboten	74.00	Anbotek	ΗÞ
			A	verage Valu	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	25.04	34.04	6.58	34.09	31.57	54.00	-22.43	V
7206.00	19.78	37.11	7.73	34.50	30.12	54.00	-23.88	V
9608.00	18.94	39.31	9.23	34.79	32.69	54.00	-21.31	V
12010.00	poter * A	loo.	, abotek	Anboten	k Pun	54.00	Aupo.	V
14412.00	Anbotek	Aupor	abotek .	Aupor	K VUD	54.00	tek Vu	V
4804.00	29.12	34.04	6.58	34.09	35.65	54.00	-18.35	Aupore H
7206.00	21.87	37.11	7.73	34.50	32.21	54.00	-21.79	P.H
9608.00	18.56	39.31	9.23	34.79	32.31	54.00	-21.69	Hari
12010.00	*	potek	Aupore	Andotek	Anbotek	54.00	Anbote	Н
14412.00	*	anbotek	Anbore	note note	k Anbote	54.00	lek "A	o ^{tek} H



Test Results (1GHz-25GHz)

Test Mode:	CH39			Test	channel: Mide	dle		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	36.16	34.38	6.69	34.09	43.14	74.00	-30.86	botck
7323.00	31.07	37.22	7.78	34.53	41.54	74.00	-32.46	AnbVel
9764.00	30.79	39.46	9.35	34.80	44.80	74.00	-29.20	V
12205.00	*	otek A	abotek P	"upor	An botek	74.00	Vup.	V
14646.00	*	*otek	Anbotek	Aupote	An potek	74.00	Anb	ek V
4882.00	40.21	34.38	6.69	34.09	47.19	74.00	-26.81	H
7323.00	32.72	37.22	7.78	34.53	43.19	74.00	-30.81	Hek
9764.00	30.11	39.46	9.35	34.80	44.12	74.00	-29.88	Aupo.
12205.00	*nbote	Aug.	otek v	nbotek	Aupote	74.00	Anbotek	H
14646.00	kek * Anbr	Ver Vi	tek p	anbotek	Anboten	74.00	Anbotek	H
	'		A	verage Value	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	25.20	34.38	6.69	34.09	32.18	54.00	-21.82	V
7323.00	19.89	37.22	7.78	34.53	30.36	54.00	-23.64	V
9764.00	19.04	39.46	9.35	34.80	33.05	54.00	-20.95	V
12205.00	poter * A	loo tek	hotek	Anboten	k Pun	54.00	Aupo	V
14646.00	Anbotek	Aupor	abotek .	Anbore	N VUD	54.00	tek bu	V
4882.00	29.30	34.38	6.69	34.09	36.28	54.00	-17.72	Aupore H
7323.00	21.99	37.22	7.78	34.53	32.46	54.00	-21.54	P.H
9764.00	18.67	39.46	9.35	34.80	32.68	54.00	-21.32	Han
12205.00	otek *	potek	Aupore	Andotek	Anbotek	54.00	Anbote	Н
14646.00	*	anbotek	Aupore	P. P. Pole	k Anbote	54.00	16K "A	ote ^K H



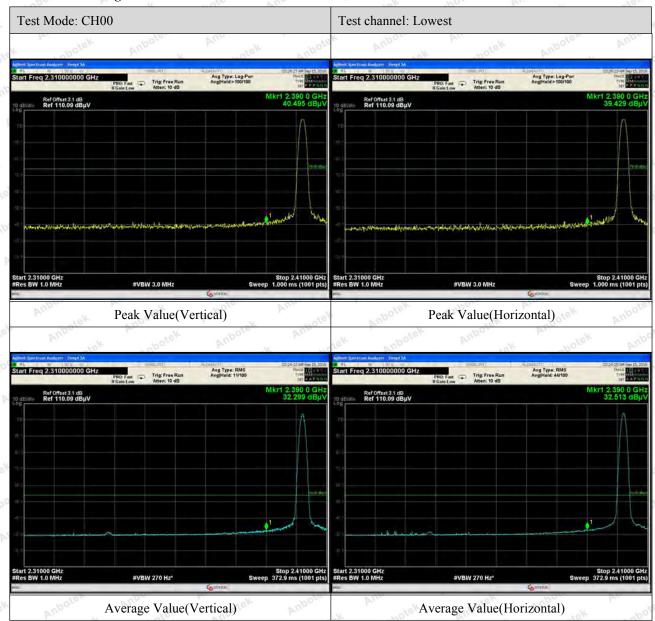
Test Results (1GHz-25GHz)

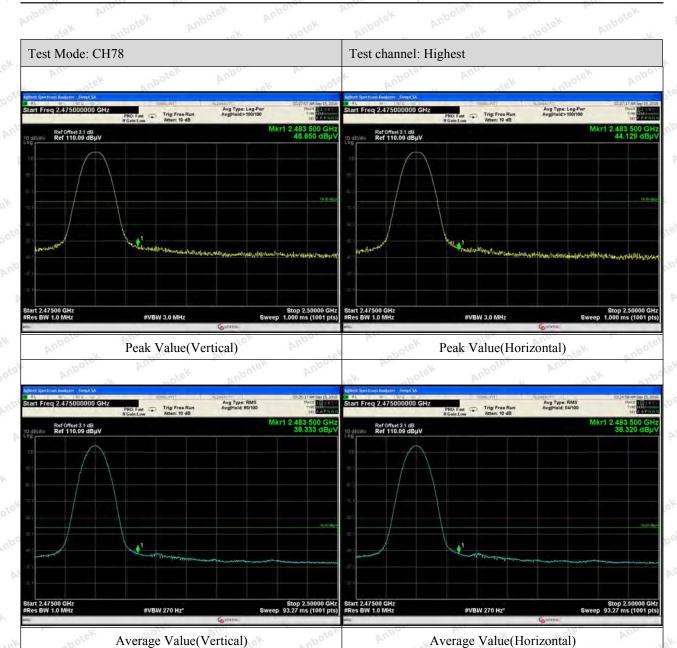
Test Mode: 0	CH78			Test	Test channel: Highest				
				Peak Value					
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.	
4960.00	35.95	34.72	6.79	34.09	43.37	74.00	-30.63	bote	
7440.00	30.93	37.34	7.82	34.57	41.52	74.00	-32.48	anbVek	
9920.00	30.67	39.62	9.46	34.81	44.94	74.00	-29.06	V	
12400.00	*	Jek Note	botek p	upoto	Au.	74.00	Aupo	V	
14880.00	* Anb	stek	nbotek	Anbotek	Yun Potek	74.00	Aupor	v V	
4960.00	39.96	34.72	6.79	34.09	47.38	74.00	-26.62	Н	
7440.00	32.57	37.34	7.82	34.57	43.16	74.00	-30.84	H'A	
9920.00	29.97	39.62	9.46	34.81	44.24	74.00	-29.76	Anboro	
12400.00	*nbote	Aupo	* 6K	botek	Anbotek	74.00	Anbotek	PH ^{bo}	
14880.00	lek * Anbe	lek Ar	Por b	"polek	Anboren	74.00	Nhotek	ΗÞ	
			A	verage Valu	e	W.V.			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.	
4960.00	25.07	34.72	6.79	34.09	32.49	54.00	-21.51	V	
7440.00	19.80	37.34	7.82	34.57	30.39	54.00	-23.61	V	
9920.00	18.96	39.62	9.46	34.81	33.23	54.00	-20.77	V	
12400.00	potek * Ar	Por	potek botek	Anbotes	Anbo	54.00	Aupo,	V	
14880.00	**	Anboro	An botek	Anbott	Ambo	54.00	rek Au	V	
4960.00	29.15	34.72	6.79	34.09	36.57	54.00	-17.43	Aupoter.	
7440.00	21.89	37.34	7.82	34.57	32.48	54.00	-21.52	ÞΉ	
9920.00	18.58	39.62	9.46	34.81	32.85	54.00	-21.15	Han	
12400.00	*	potek	Yupote.	And	Anbotek	54.00	An:	Н	
14880.00	*	botek	Anbotes	Vuo.	k abote	54.00	-/- P.	ote ^K H	

Remark

- 1. During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level =Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor
- 3. "*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.

Radiated Band Edge:





Remark:

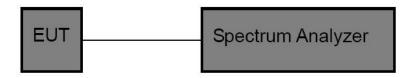
- 1. During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level =Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor

5. Maximum Peak Output Power Test

5.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (b)(3)	And Motek Anbotek	Aupor Air
Test Limit	1W or 125 mW	ak hotek Anbotek	Anbot

5.2. Test Setup



5.3. Test Procedure

- 1. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram above,
- 2. Spectrum Setting:

RBW > the 20 dB bandwidth of the emission being measured

Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel

VBW ≥ RBW

Sweep = auto

Detector function = peak

Trace = \max hold

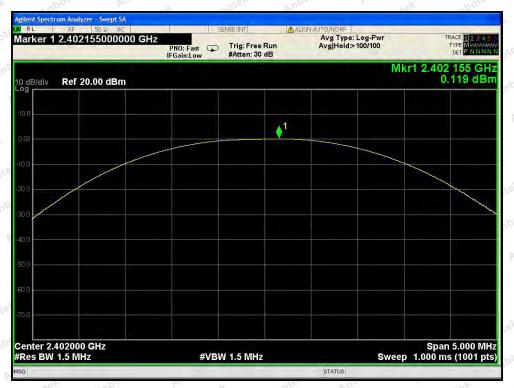
5.4. Test Data

Test Item	:	Max. peak output power	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 3.7V Battery inside	Temperature	:	23.6℃
Test Result	:	PASS	Humidity	:	56%RH

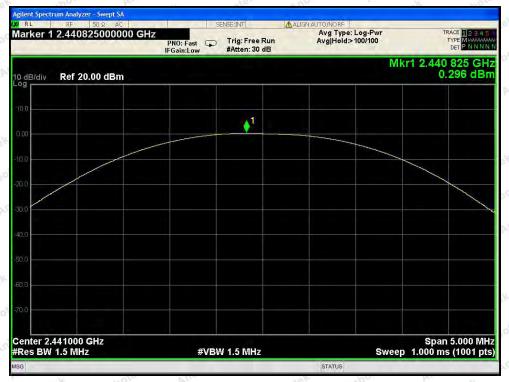
Channel Frequency (MHz)	Peak Power output (dBm)	Limit (dBm)	Results	Modulation
2402	0.199	30	PASS	BDR botek
2441	0.296	30	PASS	BDR
2480	1.224	30	PASS	BDR
2402	-1.782	20.96	PASS	EDR
2441	-1.983	20.96	PASS	EDR
2480	-0.960	20.96	PASS	EDR
otek anbore	Pur N NO.	ek Aupo.	No.	pore, but

Remark: The EDR was tested on $(\pi/4DQPSK, 8DPSK)$ modes, only the worst data of (8DPSK) is attached in the following pages.



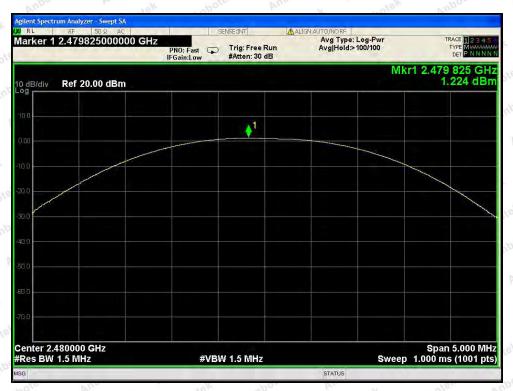


Test Mode: BDR---Low



Test Mode: BDR---Middle





Test Mode: BDR---High



Test Mode: EDR---Low





Test Mode: EDR---Middle



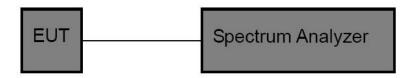
Test Mode: EDR---High

6. 20DB Occupy Bandwidth Test

6.1. Test Standard

Test Standard	FCC Part15 C Section 15.247 (a)(1)	Ans	-potek	Anbo	be.
105t Standard	1 CC 1 art 13 C Section 13.247 (a)(1)	4020	Vision	1816	

6.2. Test Setup



6.3. Test Procedure

Using the following spectrum analyzer settings:

- 1. Span= approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel.
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

6.4. Test Data

Test Item	:	20dB BW	Test Mode	: 1	CH Low ~ CH High

Test Voltage : DC 3.7V Battery inside Temperature : 23.6° C Test Result : PASS Humidity : 56%RH

o ^t	Channel Frequency(MHz)		20dB Down BW(kHz)	Modulation Mode		
200	Low	2402	911.2	BDR		
N.	Middle	2441	888.7	BDR		
	Anbo High Anbo	2480	891.2	BDR		
4	Low	2402	1210.0	EDR		
Net C	Middle	2441	1206.0	EDR		
doo's	High	2480	1205.0	EDR		

Remark: The EDR was tested on $(\pi/4DQPSK, 8DPSK)$ modes, only the worst data of (8DPSK) is attached in the following pages.





Test Mode: BDR---Low



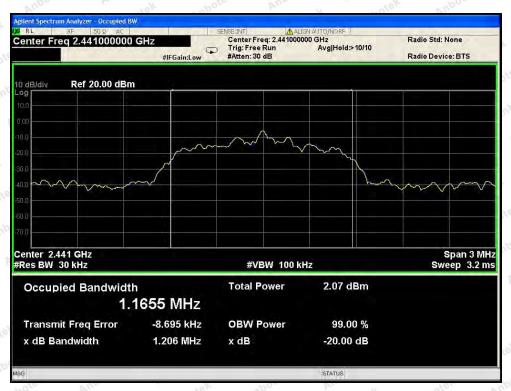
Test Mode: BDR---Middle



Test Mode: BDR---High



Test Mode: EDR---Low



Test Mode: EDR---Middle



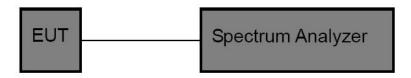
Test Mode: EDR---High

7. Carrier Frequency Separation Test

7.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (a)(1)	Anbotek	Anbo. Atek
Test Limit	>25KHz or >two-thirds of the 20 dB bandwidth	Anbotek	Anbo

7.2. Test Setup



7.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer settings:

- 1. Span= Wide enough to capture the peaks of two adjacent channels
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

7.4. Test Data

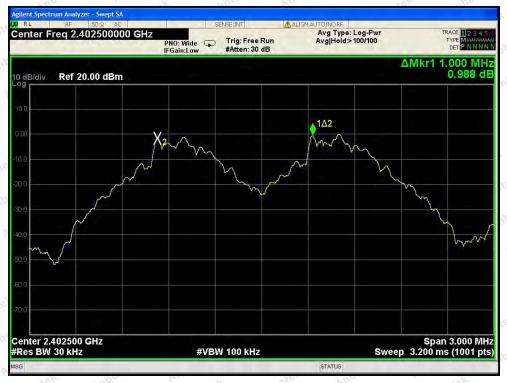
Test Item	:	Frequency Separation	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 3.7V Battery inside	Temperature	:	23.6°C
Test Result	:	PASS	Humidity	:	56%RH

Channel	Frequency	Separation Read	Limit	Modulation Mode
	(MHz)	Value (kHz)	(kHz)	Modulation Mode
Low	2402	1000	911.2	BDR
Middle	2441	1000	888.7	BDR
High	2480	1000	891.2	nbotek BDR Anbot
Low	2402	1000	806.7	EDR And
Middle	2441	1000	804.0	EDR
High	2480	1000	803.3	EDR

Remark:

- 1. The limit of mode (EDR) is 2/3 of 20dB BW;
- 2. The EDR was tested on (π /4DQPSK, 8DPSK) modes, only the worst data of (8DPSK) is attached in the following pages.



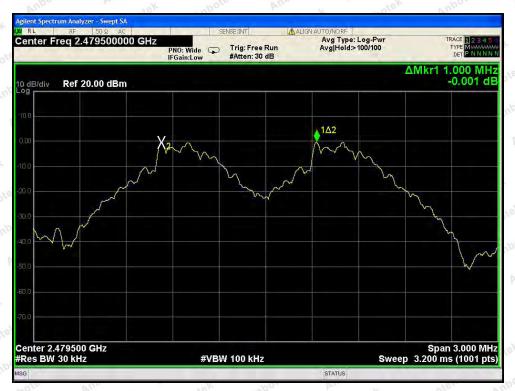


Test Mode: BDR---Low



Test Mode: BDR---Middle





Test Mode: BDR---High



Test Mode: EDR---Low





Test Mode: EDR---Middle



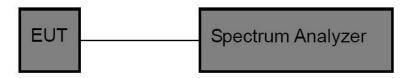
Test Mode: EDR---High

8. Number of Hopping Channel Test

8.1. Test Standard and Limit

Test Standard	FCC Part15 C	Section 15.2	247 (a)(1)	Anshotek	Anbotek	Anbo	p.
Test Limit	>15 channels	Anbotek	Anboro	An	Anboten	Anbo	K

8.2. Test Setup



8.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer setting:

- 1. Span= the frequency band of operation
- 2. Set the RBW = 100kHz.
- 3. Set the VBW = 300kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

8.4. Test Data

Test Item	: Number of Hopping Frequency	Test Mode :	CH Low ~ CH High
Test Voltage	: DC 3.7V Battery inside	Temperature :	23.6℃
Test Result	: PASS	Humidity :	56%RH

Hopping Channel Frequency Range	Quantity of Hopping Channel	Quantity of Hopping Channel	
2402-2480MHz	Amb 79 botek Ambo	>15	





BDR Mode



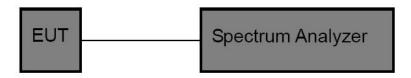
EDR Mode

9. Dwell Time Test

9.1. Test Standard and Limit

Test Standard	FCC Part15	C Section 15.2	47 (a)(1)	Ambotek	Anbotek	Anbo	b.
Test Limit	0.4 sec	Anbotek	Anboro	Arr. hotek	Anbotek	Anbo	F .

9.2. Test Setup



9.3. Test Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

- 1. Span= zero span, centered on a hopping channel
- 2. Set the RBW = 1 MHz.
- 3. Set the VBW = 1 MHz.
- 4. Sweep time = as necessary to capture the entire dwell time per hopping channel.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

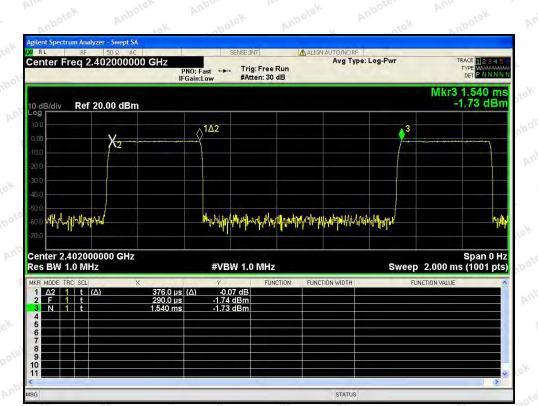
9.4. Test Data

Test Item : Time of Occupancy Test Mode : CH Low ~ CH High

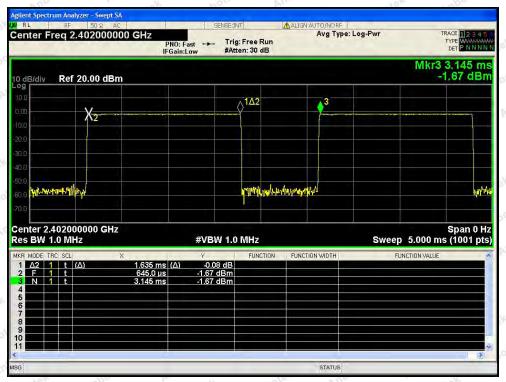
Test Voltage : DC 3.7V Battery inside Temperature : 23.6° C Test Result : PASS Humidity : 56° RH

Package Type	Pulse width (ms)	Time slot length(ms)	Dwell time (ms)	Limit (s)	Modulation
DH1	0.376	time slot length *1600/2 /79 * 31.6	120.32	0.4	BDR
DH3	1.635	time slot length *1600/4 /79 * 31.6	261.60	0.4	BDR
DH5	2.888	time slot length *1600/6 /79 * 31.6	308.05	0.4	BDR
3DH1	0.398	time slot length *1600/2 /79 * 31.6	127.36	0.4	EDR
3DH3	1.650	time slot length *1600/4 /79 * 31.6	264.00	0.4	EDR
3DH5	2.888	time slot length *1600/6 /79 * 31.6	308.05	0.4	EDR

Remark: The EDR was tested on ($\pi/4$ DQPSK, 8DPSK) modes, only the worst data of (8DPSK) is attached in the following pages.

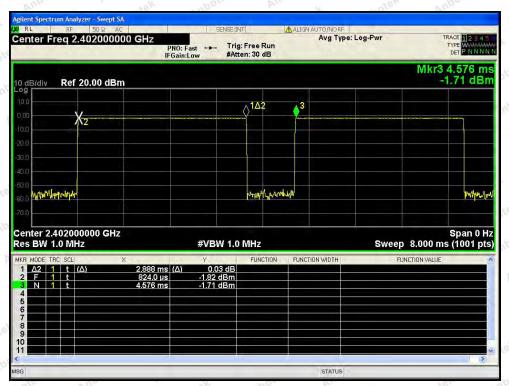


Test Mode: BDR---DH1

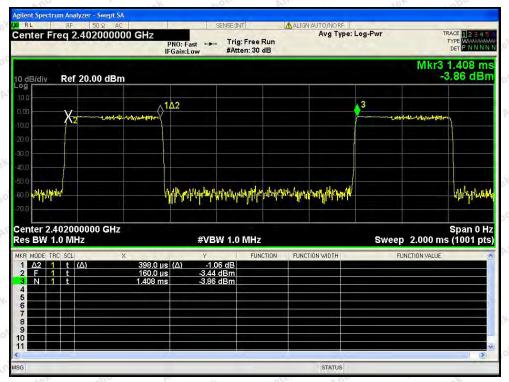


Test Mode: BDR---DH3



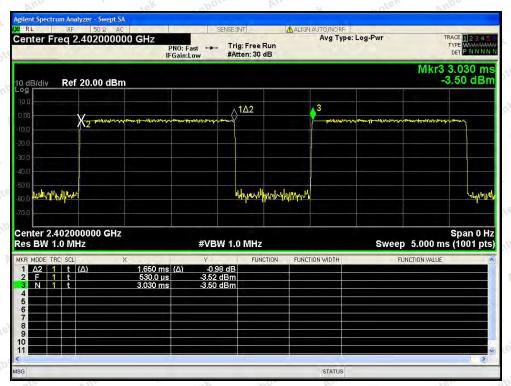


Test Mode: BDR—DH5

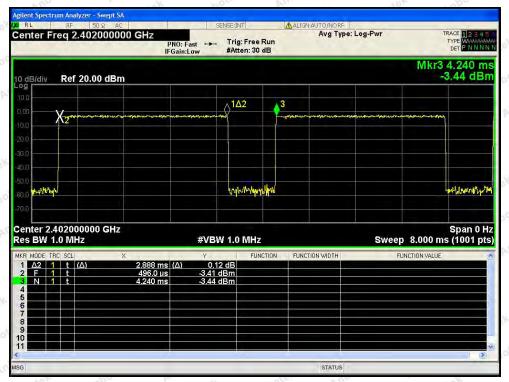


Test Mode: EDR---3DH1





Test Mode: EDR---3DH3



Test Mode: EDR—3DH5

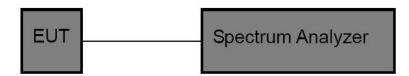
FCC ID: 2ACE5-EL7040RG

10. 100kHz Bandwidth of Frequency Band Edge Requirement

10.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (d)
Test Limit	in any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator in operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in 15.209(a).

10.2. Test Setup



10.3. Test Procedure

The EUT must have its hopping/Non-hopping function enabled. Using the following spectrum analyzer setting:

- 1. Set the RBW = 100kHz.
- 2. Set the VBW = 300kHz.
- 3. Sweep time = auto couple.
- 4. Detector function = peak.
- 5. Trace mode = max hold.
- 6. Allow trace to fully stabilize.

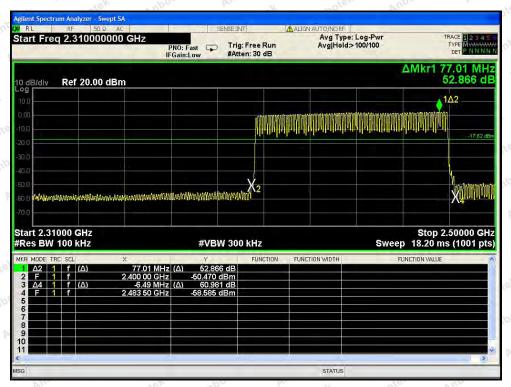
10.4. Test Data

Test Item : Band edge : CH Low ~ CH High Test Voltage : DC 3.7V Battery inside : 23.6°C

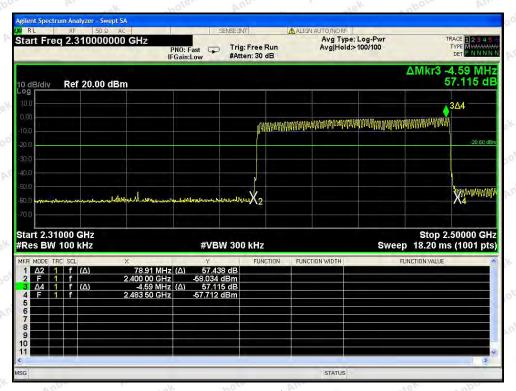
Test Result : PASS Humidity : 56%RH

Remark: The EDR was tested on $(\pi/4DQPSK, 8DPSK)$ modes, only the worst data of $(\pi/4DQPSK)$ is attached in the following pages.

For Hopping Mode



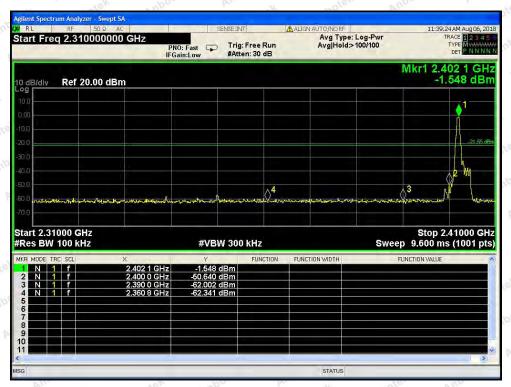
BDR mode



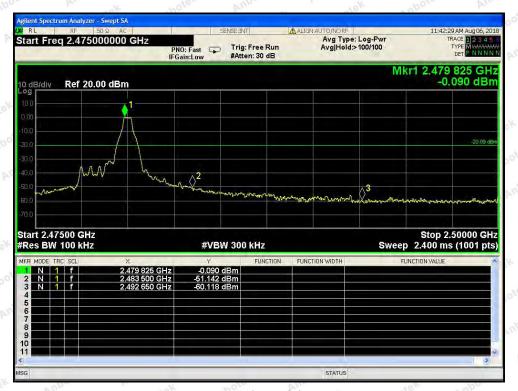
EDR mode



For Non-Hopping Mode



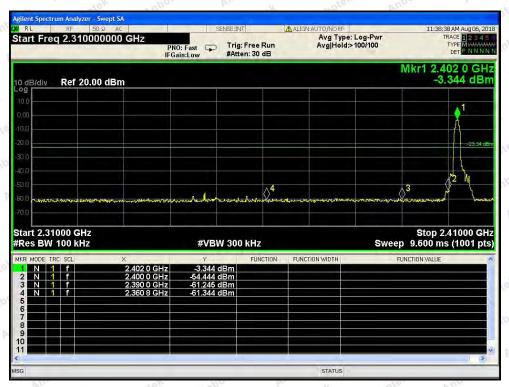
BDR mode -- Lowest



BDR mode -- Highest



For Non-Hopping Mode

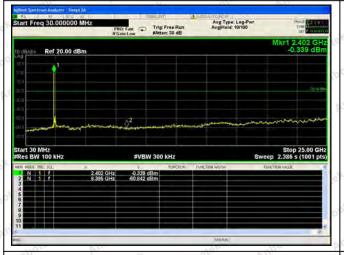


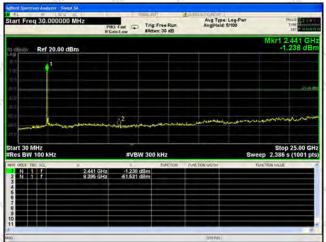
EDR mode -- Lowest



EDR mode -- Highest

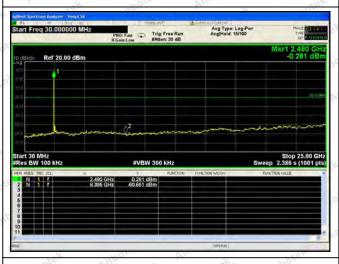
Conducted Emission Method

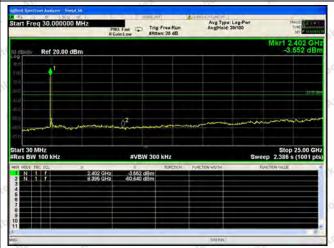




Test Mode: BDR---Low

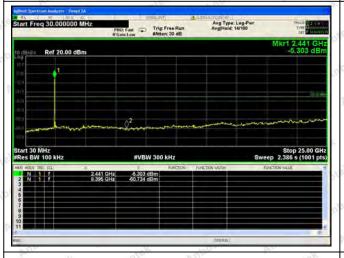
Test Mode: BDR---Mid

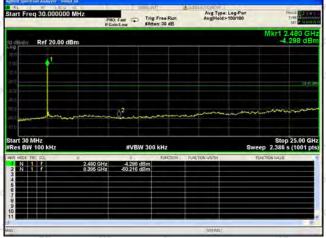




Test Mode: BDR---High

Test Mode: EDR---Low





Test Mode: EDR---Mid

Test Mode: EDR---High

11. Antenna Requirement

11.1. Test Standard and Requirement

Test Standard	FCC Part15 Section 15.203 /247(c)
	1) 15.203 requirement:
	An intentional radiator shall be designed to ensure that no antenna other than that furnished
	by the responsible party shall be used with the device. The use of a permanently
	attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the
	manufacturer may design the unit so that a broken antenna can be replaced by the user, but
Requirement	the use of a standard antenna jack or electrical connector is prohibited.
	2) 15.247(c) (1)(i) requirement:
	Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed.
	Point-to-point operations may employ transmitting antennas with directional gain greater
	than 6dBi provided the maximum conducted output power of the intentional radiator is
	reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6 dBi.

11.2. Antenna Connected Construction

The bluetooth antenna is PCB Antenna which permanently attached, and the best case gain of the antenna is 0 dBi. It complies with the standard requirement.



APPENDIX I -- TEST SETUP PHOTOGRAPH

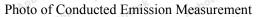
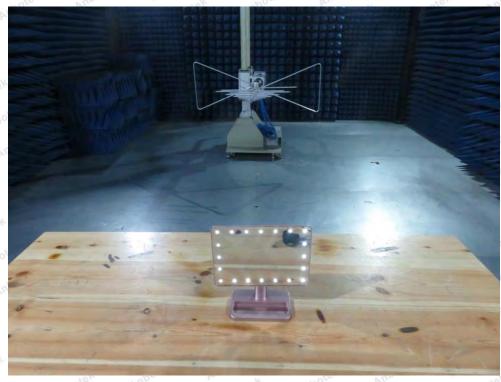




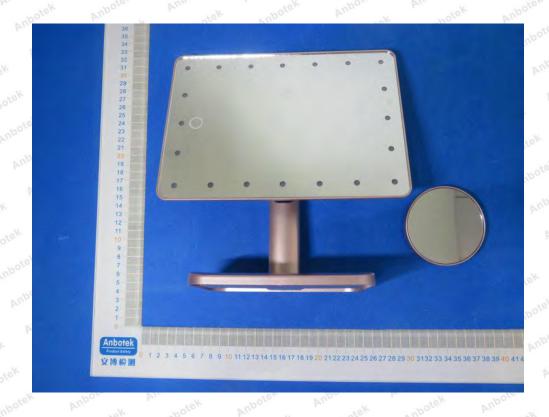
Photo of Radiation Emission Test







APPENDIX II -- EXTERNAL PHOTOGRAPH









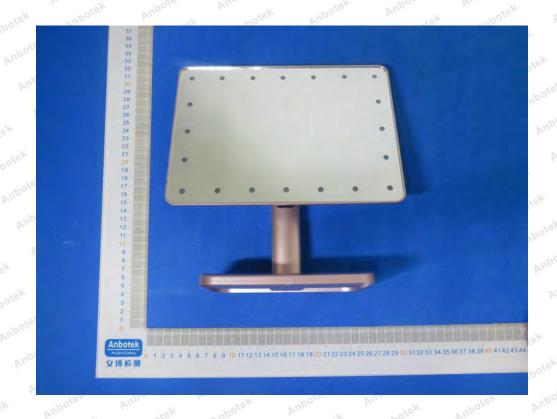












APPENDIX III -- INTERNAL PHOTOGRAPH











----- End of Report -